

July 2013

FQD10N20C / FQU10N20C

N-Channel QFET® MOSFET 200 V, 7.8 A, 360 m Ω

Description

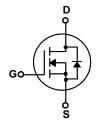
This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 7.8 A, 200 V, $R_{DS(on)}$ = 360 m Ω (Max.)@ V_{GS} = 10 V, I_D = 3.9 A
- Low Gate Charge (Typ. 20 nC)
- Low Crss (Typ. 40.5 pF)
- · 100% Avalanche Tested







Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQD10N20C / FQU10N20C	Unit
V _{DSS}	Drain-Source Voltage		200	V
I _D	Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		7.8	Α
			5.0	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	31.2	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	210	mJ
I _{AR}	Avalanche Current	(Note 1)	7.8	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns
P_{D}	Power Dissipation (T _C = 25°C)		50	W
	- Derate above 25°C		0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	FQD10N20C / FQU10N20C	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient*	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	110	°C/W

Symbol	Parameter	Parameter Test Conditions		Тур	Max	Unit
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA				V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25	°C	0.28		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 200 V, V _{GS} = 0 V			10	μΑ
		V _{DS} = 160 V, T _C = 125°C	-		100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	racteristics		·			
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 3.9 A		0.29	0.36	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 3.9 A		5.6		S
C _{iss}	Input Capacitance Output Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		395 97	510 125	pF pF
		50				•
C _{rss}	Reverse Transfer Capacitance			40.5	53	pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 100 V, I _D = 9.5 A,		11	30	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		92	190	ns
t _{d(off)}	Turn-Off Delay Time			70	150	ns
t _f	Turn-Off Fall Time	(Note	e 4)	72	160	ns
Qg	Total Gate Charge	V _{DS} = 160 V, I _D = 9.5 A,		20	26	nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V		3.1		nC
Q_{gd}	Gate-Drain Charge	(Note	= 4)	10.5		nC
Drain-S	Source Diode Characteristics a	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				7.8	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	sed Drain-Source Diode Forward Current			31.2	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 7.8 A			1.5	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_S = 9.5 \text{ A},$		158		ns
^		41 / 44 — 400 A /				

 $dI_F / dt = 100 A/\mu s$

Q_{rr}

Reverse Recovery Charge

μС

0.97

Notes:1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 5.2mH, I_{AS} = 7.8A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C 3. $I_{SD} \le 9.5$ A, di/dt ≤ 300 A/ μ s, $V_{DD} \le BV_{DSS}$, Starting T_J = 25°C 4. Essentially independent of operating temperature

Typical Characteristics

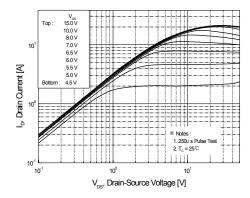


Figure 1. On-Region Characteristics

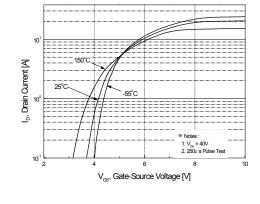


Figure 2. Transfer Characteristics

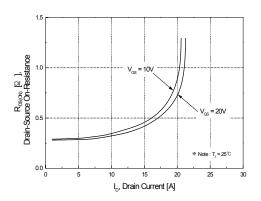


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

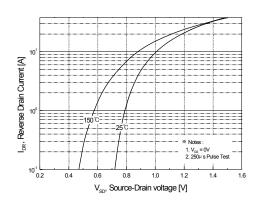


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

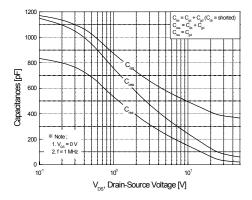


Figure 5. Capacitance Characteristics

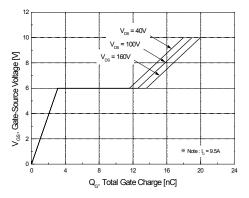
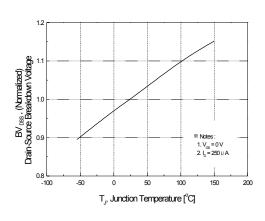


Figure 6. Gate Charge Characteristics



Typical Characteristics (Continued)

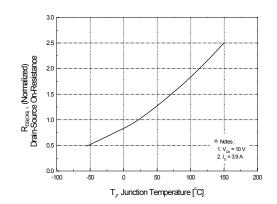
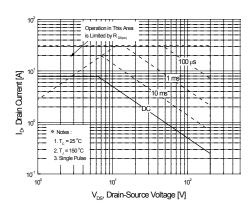


Figure 7. Breakdown Voltage Variation vs Temperature

Figure 8. On-Resistance Variation vs Temperature



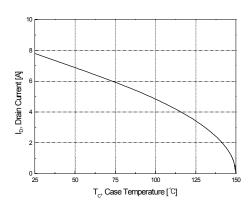


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs Case Temperature

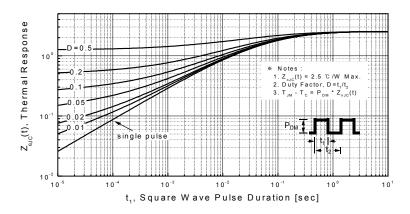
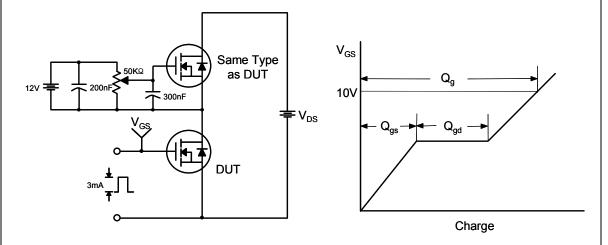
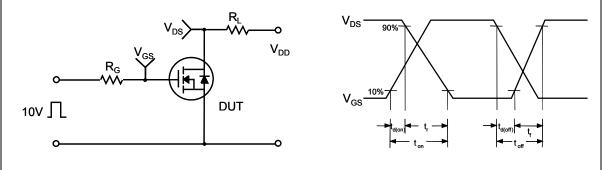


Figure 11. Transient Thermal Response Curve

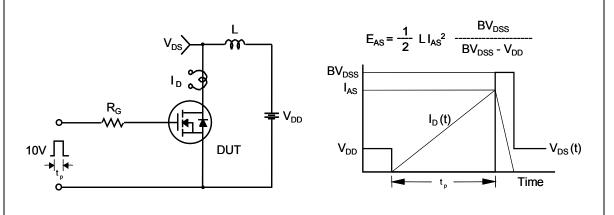
Gate Charge Test Circuit & Waveform



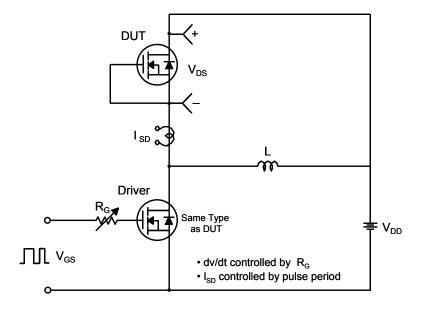
Resistive Switching Test Circuit & Waveforms

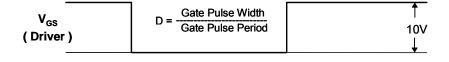


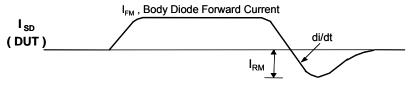
Unclamped Inductive Switching Test Circuit & Waveforms



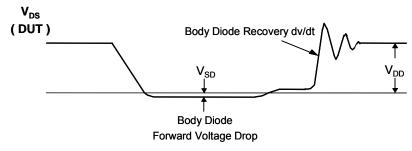
Peak Diode Recovery dv/dt Test Circuit & Waveforms





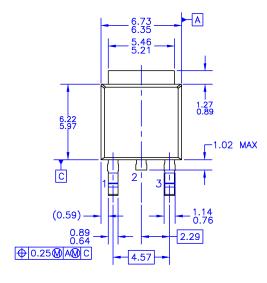


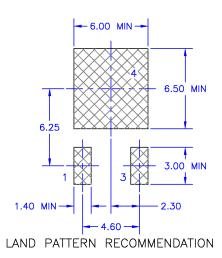
Body Diode Reverse Current



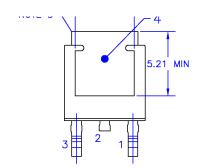
Mechanical Dimensions

D-PAK





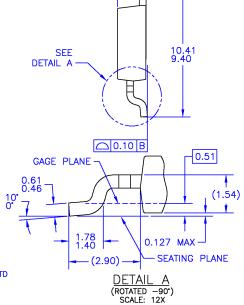
0.58



NOTES: UNLESS OTHERWISE SPECIFIED

- UNLESS OTHERWISE SPECIFIED
 THIS PACKAGE CONFORMS TO JEDEC, TO-252,
 ISSUE C, VARIATION AA.
 ALL DIMENSIONS ARE IN MILLIMETERS.
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 DIMENSIONING AND TOLERANCING PER
 ASME Y14.5M-1994.
 HEAT SINK TOP EDGE COULD BE IN CHAMFERED
 CORNERS OR EDGE PROTRUSION.
 PRESENCE OF TRIMMED CENTER LEAD
 IS OPTIONAL.
- E)
- F)
- IS UPTIONAL.
 DIMENSIONS ARE EXCLUSSIVE OF BURSS,
 MOLD FLASH AND TIE BAR EXTRUSIONS.
 LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD
 T0220P1003X238-3N.

DRAWING NUMBER AND REVISION: MKT-T0252A03REV8



TO-252 (DPAK) MOLDED, 3 LEAD, OPTION AA

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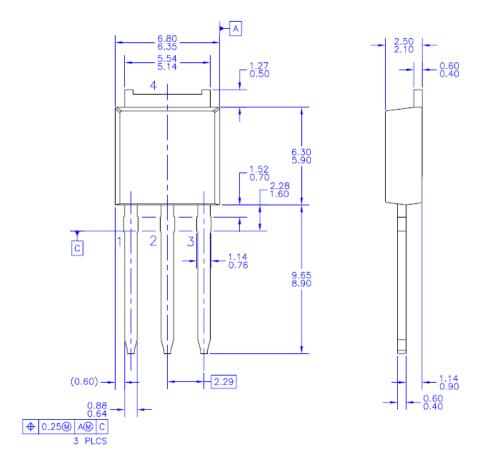
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Mechanical Dimensions

I-PAK





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Dimensions in Millimeters





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